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ATTORNEY DOCKET NO. APPLICATION NO. FILING DATE FIRST NAMED INVENTOR CONFIRMATION NO. 9578 09/29/2000 M-8570 US 09/675,627 Michael Rumer **EXAMINER** 34036 7590 02/20/2004 SILICON VALLEY PATENT GROUP LLP PERKINS, PAMELA E 2350 MISSION COLLEGE BOULEVARD PAPER NUMBER ART UNIT **SUITE 360** SANTA CLARA, CA 95054 2822

DATE MAILED: 02/20/2004

Please find below and/or attached an Office communication concerning this application or proceeding.

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		Applica	ation No.	Applicant(s)	
		09/675	,627	RUMER ET AL.	
Office Action Summary		Examir	ner	Art Unit	
		Pamela	E Perkins	2822	
Period fo	Th MAILING DATE of this commun or Reply	ication appears on t	th coversh twit	h the correspondenc ad	dress
THE   - Extermination of the aftermination of the a	ORTENED STATUTORY PERIOD FOMAILING DATE OF THIS COMMUNI insigns of time may be available under the provisions SIX (6) MONTHS from the mailing date of this common period for reply specified above is less than thirty (30) period for reply is specified above, the maximum state to reply within the set or extended period for reply eply received by the Office later than three months and patent term adjustment. See 37 CFR 1.704(b).	CATION. of 37 CFR 1.136(a). In no nunication. O) days, a reply within the s atutory period will apply and will, by statute, cause the a	event, however, may a re statutory minimum of thirty d will expire SIX (6) MON application to become AB/	rply be timely filed  (30) days will be considered timel  (FHS from the mailing date of this co	
1)🖂	Responsive to communication(s) file	d on <u>13 October 2</u>	<u>003</u> .		
2à)□	This action is FINAL. 2b)⊠ This action is non-final.				
3)□	Since this application is in condition for allowance except for formal matters, prosecution as to the ments is closed in accordance with the practice under <i>Ex parte Quayle</i> , 1935 C.D. 11, 453 O.G. 213.				
Disposition of Claims					
5)□ 6)⊠ 7)□	<ul> <li>☑ Claim(s) 1-30 is/are pending in the application.</li> <li>4a) Of the above claim(s) is/are withdrawn from consideration.</li> <li>☐ Claim(s) is/are allowed.</li> <li>☑ Claim(s) 1-10 and 18-30 is/are rejected.</li> <li>☐ Claim(s) is/are objected to.</li> <li>☑ Claim(s) 11-17 are subject to restriction and/or election requirement.</li> </ul>				
Applicat	ion Papers				
9) The specification is objected to by the Examiner.  10) The drawing(s) filed on is/are: a) accepted or b) objected to by the Examiner.  Applicant may not request that any objection to the drawing(s) be held in abeyance. See 37 CFR 1.85(a).  Replacement drawing sheet(s) including the correction is required if the drawing(s) is objected to. See 37 CFR 1.121(d).  11) The oath or declaration is objected to by the Examiner. Note the attached Office Action or form PTO-152.					
Priority under 35 U.S.C. §§ 119 and 120					
12)	Acknowledgment is made of a claim  All b) Some copies of the priority  Certified copies of the priority  Copies of the certified copies of application from the Internation from the attached detailed Office action from the foreign from the foreign land from the from the foreign land from the foreign from the foreign from the first sent from the first se	documents have be documents have be of the priority document Bureau (PCT Fin for a list of the celebrate domestic priority density and the first sentent aguage provisional for domestic priority	een received. een received in Apments have been Rule 17.2(a)). ertified copies not a under 35 U.S.C. ace of the specification has been application has been application.	oplication No received in this National received. § 119(e) (to a provisiona ation or in an Application een received. §§ 120 and/or 121 since	l application) Data Sheet. a specific
Attachment(s)					
2) Notic	e of References Cited (PTO-892) se of Draftsperson's Patent Drawing Review (P mation Disclosure Statement(s) (PTO-1449) P			ummary (PTO-413) Paper No( formal Patent Application (PT0	

#### **DETAILED ACTION**

This office action is in response the filing of the amendment on 13 October 2003.

Claims 1-30 are pending.

### Claim Rejections - 35 USC § 103

The following is a quotation of 35 U.S.C. 103(a) which forms the basis for all obviousness rejections set forth in this Office action:

(a) A patent may not be obtained though the invention is not identically disclosed or described as set forth in section 102 of this title, if the differences between the subject matter sought to be patented and the prior art are such that the subject matter as a whole would have been obvious at the time the invention was made to a person having ordinary skill in the art to which said subject matter pertains. Patentability shall not be negatived by the manner in which the invention was made.

Claims 1-4, 9, 10, 18, 20, 21 and 23-30 are rejected under 35 U.S.C. 103(a) as being unpatentable over Stevens (5,741,721) in view of Kitch et al. (6,277,726) and Yamadai (6.083,830).

Stevens discloses a method of forming a titanium layer on a substrate where a substrate is placed in a deposition chamber comprising a source of titanium, depositing the titanium layer onto the substrate in an atmosphere that comprises hydrogen (col. 14, lines 18-31). Stevens does not disclose forming the titanium layer by physical vapor deposition (PVD) and having a <002> orientation.

Kitch et al. disclose a method of forming a titanium layer on a substrate where a substrate (12) is placed in a deposition chamber comprising a source of titanium, depositing the titanium layer (13) onto the substrate by physical vapor deposition (PVD) in an atmosphere that comprises argon, then forming an aluminum layer (16) on the

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titanium layer (13). Kitch et al. further disclose forming a titanium nitride layer (15) over the titanium layer (13) (col. 5, lines 6-30).

Since Stevens and Kitch et al. are both from the same field of endeavor, a method of forming a titanium layer on a substrate, the purpose disclosed by Kitch et al. would have been recognized in the pertinent art of Stevens. Therefore, it would have been obvious to one ordinary skill in the art at the time the invention was made to modify Stevens by forming the titanium layer by physical vapor deposition (PVD) as taught by Kitch et al. to reducing the resistance of electrical coupling between conductive layers (col. 1, lines 8-11).

Yamadai discloses a method of forming a layer on a substrate where a titanium layer (3), with a <002> orientation, is sputter deposited on a substrate (1), then a titanium nitride layer (4), with a preferred <111> orientation, is formed on the titanium layer (3) and an aluminum layer (5), with a <111> orientation, is formed on the titanium nitride layer (4) (col. 3, line 17 thru col. 5, line 41; col. 5, lines 1-33).

Since Stevens and Yamadai are both from the same field of endeavor, a method of forming a titanium layer on a substrate, the purpose disclosed by Yamadai would have been recognized in the pertinent art of Stevens. Therefore, it would have been obvious to one of ordinary skill in the art at the time the invention was made to modify Stevens by the titanium layer having a <002> orientation, the titanium nitride layer having a <111> orientation and the aluminum layer having a <111> orientation as taught by Yamadai. A titanium layer with a <002> orientation prevents the formation of side-hole, openings in the sidewalls (col. 2, lines 21-55).

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Referring to claim 29, Stevens does not disclose absorbing the hydrogen to a depth of about 50 Angstroms into the titanium target. It would have been obvious to one having ordinary skill in the art at the time invention was made to absorb the hydrogen to a depth of about 50 Angstroms into the titanium target, disclosed in the claimed invention, since it has been held that where the general conditions of a claim are disclosed in the prior art, discovering the optimum or workable ranges involves only routine skill in the art. *In re Aller*, 105 USPQ 233 (CCPA 1955).

Claims 5 and 8 are rejected under 35 U.S.C. 103(a) as being unpatentable over Stevens in view of Kitch et al. and Yamadai as applied to claims 1-4, 9, 10,18, 20 and 21 above, and further in view of Freeman et al. (5,466,522).

Stevens discloses a method of forming a titanium layer on a substrate where a substrate is placed in a deposition chamber comprising a source of titanium, depositing the titanium layer onto the substrate in an atmosphere that comprises hydrogen (col. 14, lines 18-31). Stevens in view of Kitch et al. and Yamadai do not disclose the gas mixture during sputter deposition comprising at least 0.1 mole percent hydrogen.

Freeman et al. a method of forming a layer over a substrate where a substrate is placed in a sputter chamber containing a gas mixture of argon and hydrogen in the atmosphere and sputter depositing a layer over the substrate. Freeman et al. further disclose the gas mixture comprising at least 4 mole percent hydrogen (col. 4, lines 7-57).

Since Stevens and Freeman et al. are both from the same field of endeavor, a method of forming a titanium layer on a substrate, the purpose disclosed by Freeman et

al. would have been recognized in the pertinent art of Stevens. Therefore, it would have been obvious to one of ordinary skill in the art at the time the invention was made to modify Stevens by the gas mixture during sputter deposition comprising at least 4 mole percent hydrogen as taught by Freeman et al. The higher the concentration of hydrogen in the atmosphere during sputter deposition there is an increase in the coercivity of the film formed on the substrate, meaning the polarity of the material changes only under the influence of a relatively large magnetic field (col. 7, lines 7-57).

Claims 6 and 7 are rejected under 35 U.S.C. 103(a) as being unpatentable over Stevens in view of Kitch et al. and Yamadai as applied to claims 1-4, 9, 10,18, 20 and 21 above, and further in view of Kaloyeros et al. (6,139,922).

Stevens discloses a method of forming a titanium layer on a substrate where a substrate is placed in a deposition chamber comprising a source of titanium, depositing the titanium layer onto the substrate in an atmosphere that comprises hydrogen (col. 14, lines 18-31). Stevens in view of Kitch et al. and Yamadai do not disclose providing power to the target with a power density of 3 to 8 watts per square centimeter.

Kaloyeros et al. disclose a method of forming a film over a substrate by a method of sputtering. Kaloyeros et al. further disclose the power used in the sputtering method having a power density of between 0.01 W/cm² and 10 W/cm² (col. 10, lines 60-67; col. 11, lines 1-17).

Since Stevens and Kaloyeros et al. are both from the same field of endeavor, a method of forming a titanium layer on a substrate, the purpose disclosed by Kaloyeros et al. would have been recognized in the pertinent art of Baum et al. Therefore, it would

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have obvious to one of ordinary skill in the art at the time the invention was made to modify Baum et al. by applying powering to the target with a power density of 0.01 W/cm² to 10 W/cm² as taught by Kaloyeros et al. Under such conditions undesirable film contamination and electrical damage to the film are prevented (col. 11, lines 1-17).

Claims 19 and 22 are rejected under 35 U.S.C. 103(a) as being unpatentable over Stevens in view of Kitch et al. and Yamadai as applied to claims 1-4, 9, 10,18, 20 and 21 above, and further in view of Hsu et al. (6,329,282).

Stevens discloses a method of forming a titanium layer on a substrate where a substrate is placed in a deposition chamber comprising a source of titanium, depositing the titanium layer onto the substrate in an atmosphere that comprises hydrogen (col. 14, lines 18-31). Stevens in view of Kitch et al. and Yamadai do not disclose the aluminum layer with a full width at half maximum (FWHM) x-ray diffraction signal of less than about 1.5 degrees.

Hsu et al. disclose a method of forming a titanium (9), titanium nitride (11), aluminum (19) interconnect. Hsu et al. further disclose the aluminum layer having a FWHM of 1.5 degrees (col. 3, lines 11-65).

Since Stevens and Hsu et al. are both from the same field of endeavor, a method of forming a titanium layer on a substrate, the purpose disclosed by Hsu et al. would have been recognized in the pertinent art of Stevens. Therefore, it would have obvious to one of ordinary skill in the art at the time the invention was made to modify Stevens by the aluminum layer having a FWHM of 1.5 degrees as taught by Hsu et al. because it improve the crystallographic orientation of the aluminum layer.

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Hsu et al. do not disclose the aluminum layer having a FWHM of less than 1.5 degrees. It would have been obvious to one having ordinary skill in the art at the time invention was made to have a FWHM of less than 1.5 degrees for the aluminum layer, since it has been held that where the general conditions of a claim are disclosed in the prior art, discovering the optimum or workable ranges involves only routine skill in the art. *In re Aller*, 105 USPQ 233 (CCPA 1955).

#### Allowable Subject Matter

Claims 11-17 are allowed.

The following is a statement of reasons for the indication of allowable subject matter: prior art does not anticipate, teach, or suggest a method of forming a titanium layer on a substrate where the substrate is placed is a sputtering chamber comprising a titianium target, flowing a first gas comprisine hydrogen into the sputtering chamber through a first gas injector, terminating the flow of the first gas, after the flow of the first gas has been terminated, sputter depositing the titanium layer onto the substrate by applying power to the target and by providing a second gas in the sputtering chamber through a second gas inject, wherein the hydrogen is activitated and whereby the deposited titanium layer has a preferred crystal orientation.

## Response to Arguments

Applicant's arguments with respect to claims 1-22 have been considered but are most in view of the new ground(s) of rejection.

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Conclusion

Any inquiry concerning this communication or earlier communications from the

examiner should be directed to Pamela E Perkins whose telephone number is (571)

272-1840. The examiner can normally be reached on Monday thru Friday, 9:00am to

5:30pm.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's

supervisor, Amir Zarabian can be reached on (571) 272-1852. The fax phone number

for the organization where this application or proceeding is assigned is (703) 872-9306.

Any inquiry of a general nature or relating to the status of this application or

proceeding should be directed to the receptionist whose telephone number is (703) 308-

0956.

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